

Page 1 of 15

# CAPACITORS, LEADLESS SURFACE MOUNTED, TANTALUM, SOLID ELECTROLYTE, ENCLOSED ANODE CONNECTION

# **BASED ON TYPE TAJ**

ESCC Detail Specification No. 3012/001

Issue 10 July 2024



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# **ESCC Detail Specification**

No. 3012/001

PAGE 3

ISSUE 10

# **DOCUMENTATION CHANGE NOTICE**

(Refer to https://escies.org for ESCC DCR content)

DCR No.	CHANGE DESCRIPTION
<u>1671</u>	Specification upissued to incorporate changes per DCR.







ISSUE 10



1	GENERAL	5
1.1	SCOPE	5
1.2	APPLICABLE DOCUMENTS	5
1.3	TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS	5
1.4	THE ESCC COMPONENT NUMBER AND COMPONENT TYPE VARIANTS	6
1.4.1	The ESCC Component Number	6
1.4.2	Component Type Variants and Range of Components	7
1.5	MAXIMUM RATINGS	8
1.6	PHYSICAL DIMENSIONS AND TERMINAL IDENTIFICATION	9
1.7	FUNCTIONAL DIAGRAM	9
2	REQUIREMENTS	10
2.1	GENERAL	10
2.1.1	Deviations from the Generic Specification	10
2.2	MARKING	10
2.3	ELECTRICAL MEASUREMENTS AT ROOM, HIGH AND LOW TEMPERATURES	10
2.3.1	Room Temperature Electrical Measurements	10
2.3.2	High and Low Temperatures Electrical Measurements	11
2.4	INTERMEDIATE AND END-POINT ELECTRICAL MEASUREMENTS	12
APPEND	DIX A	15



### 1 **GENERAL**

### 1.1 SCOPE

This specification details the ratings, physical and electrical characteristics, and test and inspection data for the component type variants and/or the Component Type Variants and Range of Components specified below. It supplements the requirements of, and shall be read in conjunction with, the ESCC Generic Specification listed under Applicable Documents.

### 1.2 <u>APPLICABLE DOCUMENTS</u>

The following documents form part of this specification and shall be read in conjunction with it:

(a) ESCC Generic Specification No. 3012.

### 1.3 <u>TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS</u>

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESCC Basic Specification No. 21300 shall apply.



### 1.4 THE ESCC COMPONENT NUMBER AND COMPONENT TYPE VARIANTS

# 1.4.1 <u>The ESCC Component Number</u>

The ESCC Component Number shall be constituted as follows:

Example: 301200101155MA

Detail Specification Reference: 3012001

• Component Type Variant Number: 01 (as required)

• Characteristic code: Rated Capacitance (1.5µF): 155 (as required)

Characteristic code: Capacitance Tolerance (±20%): M (as required)

• Rating code: DC Rated Voltage (10V): A (as required)

### 1.4.1.1 Characteristics and Ratings Codes

Characteristics and ratings to be codified as part of the ESCC Component Number shall be as follows:

(a) Rated Capacitance, C<sub>n</sub>, expressed by means of the following codes in accordance with ESCC Basic Specification No. 21700. The unit quantity shall be picofarad (pF).

Capacitance Value C	Code
(pF)	
XX 10 <sup>4</sup>	XX4
XX 10 <sup>5</sup>	XX5
XX 10 <sup>6</sup>	XX6
XX 10 <sup>7</sup>	XX7

(b) Capacitance Tolerance expressed by the following codes in accordance with ESCC Basic Specification No. 21700:

Tolerance	Code
(± %)	
10	K
20	М

(c) DC Rated Voltage, U<sub>R</sub>, expressed by the following codes:

DC Rated Voltage UR	Code
(V)	
4	G
6.3	J
10	Α
16	С
20	D
25	Е
35	V
50	Т



### 1.4.2 <u>Component Type Variants and Range of Components</u>

The Component Type Variants and Range of Components applicable to this specification are as follows:

Variant Number	Case Code (Style) (Note 1)	Terminal Material and Finish (Note 2)	Capacitance Range C <sub>n</sub> (µF) (Notes 3, 4)	DC Rated Voltage U <sub>R</sub> (V) (Note 3)	Weight Max (g)
01	A (1206)	G16	0.1 to 10	4 to 50	0.1
02	B (1210)	G16	0.15 to 22	4 to 50	0.2
13	C (2312)	P17	0.47 to 68	4 to 50	0.3
14	D (2917)	P17	1.5 to 150	4 to 50	0.5
17	E (2917)	P17	10 to 220	4 to 50	0.7

- 1. See Para. 1.6.
- 2. Terminal material and finish shall in accordance with the requirements of ESCC Basic Specification No. 23500.
- 3. The following Rated Capacitance (C<sub>n</sub>) and DC Rated Voltage (U<sub>R</sub>) are available in the following cases (letters indicate the case code):

Capacitance				C Rated	Voltage U	R		
Cn	4V	6.3V	10V	16V	20V	25V	35V	50V
(μF)	-7 V	0.5 V	10 V	10 V	200	25 V	33 V	30 V
0.1							Α	Α
0.15							Α	В
0.22							Α	В
0.33							Α	В
0.47						Α	A, B	С
0.68					Α	Α	A, B	С
1				Α	Α	Α	В	С
1.5			Α	Α	Α	В	B, C	D
2.2		Α	Α	A, B	В	В	B, C	D
3.3	Α	Α	Α	A, B	В	B, C	С	D
4.7	Α	Α	A, B	В	B, C	С	C, D	D
6.8	Α	A, B	В	B, C	С	C, D	D	D
10	A, B	В	B, C	С	С	C, D	D	Е
15	В	B, C	С	С	C, D	D	D	
22	B, C	С	С	C, D	D	D	Е	
33	С	С	C, D	D	D	Е		
47	C, D	C, D	C, D	D	Е			
68	C, D	D	D	D	Е			
100	D	D	D	Е				
150	D	D	Е					
220	Е	Е	Е					

- 4. The following Capacitance Tolerances are available:
  - ±10% (K)
  - ±20% (M)



### 1.5 MAXIMUM RATINGS

The maximum ratings shall not be exceeded at any time during use or storage.

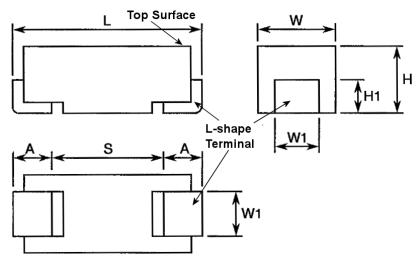
Maximum ratings shall only be exceeded during testing to the extent specified in this specification and when stipulated in Test Methods and Procedures of the ESCC Generic Specification.

Characteristics	Symbols	Maximum Ratings	Units	Remarks
DC Rated Voltage	U <sub>R</sub>	See Para. 1.4.2	V	Note 1
DC Surge Voltage	Us	1.3 x U <sub>R</sub>	V	T <sub>amb</sub> ≤ +85°C
DC Category Voltage	Uc	0.66 x U <sub>R</sub>	V	
Operating Temperature Range	Top	-55 to +125	°C	T <sub>amb</sub>
Rated Temperature	$T_R$	+85	°C	
Upper Category Temperature	Tc	+125	°C	
Storage Temperature Range	T <sub>stg</sub>	-55 to +125	°C	
Soldering Temperature	T <sub>sol</sub>	+260	°C	Note 2

- 1. At  $T_{amb} \le +85^{\circ}C$ . For  $T_{amb} > +85^{\circ}C$ , derate linearly to  $U_C$  at  $T_{amb} = +125^{\circ}C$ .
- 2. Duration 5 seconds maximum for wave soldering and 10 seconds maximum for reflow soldering. The solderable area is the terminal pad and up to 1/3 the height of the L-shape terminal (see Para. 1.6).



### 1.6 PHYSICAL DIMENSIONS AND TERMINAL IDENTIFICATION



Variant	Case		Dimensions (mm)												
Number	Code	l	_	ŀ	1	H	l1	٧	٧	V	/1	,	4		3
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max
01	Α	3	3.4	-	1.8	0.7	-	1.5	1.8	1	1.4	0.6	1.1	1.1	-
02	В	3.3	3.7	-	2.1	0.7	-	2.7	3	2	2.4	0.6	1.1	1.4	-
13	С	5.8	6.2	-	2.8	0.7	-	3.1	3.4	2	2.4	1.1	1.6	2.9	-
14	D	7.1	7.5	-	3.1	0.7	-	4.2	4.5	2.2	2.6	1.1	1.6	4.4	-
17	E	7.1	7.5	-	4.3	0.7	-	4.2	4.5	2.2	2.6	1.1	1.6	4.4	-

NOTES:

1. Terminal identification: The anode terminal shall be indicated by a polarity stripe marked on the ESCC qualified components, the ESCC qualified components. symbol may be used to indicate the anode terminal.

### 1.7 **FUNCTIONAL DIAGRAM**



Terminal 1: Anode

Terminal 2: Cathode



# 2 REQUIREMENTS

### 2.1 GENERAL

The complete requirements for procurement of the components specified herein are as stated in this specification and the ESCC Generic Specification. Permitted deviations from the Generic Specification, applicable to this specification only, are listed below.

Permitted deviations from the Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESCC requirement and do not affect the component's reliability, are listed in the appendices attached to this specification.

### 2.1.1 <u>Deviations from the Generic Specification</u>

None.

### 2.2 <u>MA</u>RKING

The marking shall be in accordance with the requirements of ESCC Basic Specification No. 21700. The information to be marked shall be:

- (a) Terminal Identification (see Para. 1.6).
- (b) The ESCC qualified components symbol (for ESCC qualified components only).
- (c) The ESCC Component Number (see Para. 1.4.1).
- (d) Traceability information.

### 2.3 <u>ELECTRICAL MEASUREMENTS AT ROOM, HIGH AND LOW TEMPERATURES</u>

Electrical measurements shall be performed at room, high and low temperatures.

### 2.3.1 Room Temperature Electrical Measurements

The measurements shall be performed at  $T_{amb} = +22 \pm 3$ °C.

Characteristics	Symbols	Test Method and Conditions	Tolerance	L	Units	
		Conditions		Min	Max	
Capacitance	С	ESCC No. 3012	±10%	0.9C <sub>n</sub>	1.1C <sub>n</sub>	μF
			±20%	0.8C <sub>n</sub>	1.2C <sub>n</sub>	
DC Leakage Current	L	ESCC No. 3012	All	-	0.01C <sub>n</sub> x U <sub>R</sub> or (1)	μA
Dissipation Factor	DF	ESCC No. 3012	All			%
		For U <sub>R</sub> < 10V:		-	6	
		For $U_R \ge 10V$ , $C \le 1\mu F$ :		-	4	
		For $U_R \ge 10V$ , $C > 1\mu F$ :		-	6	

### NOTES:

1. Whichever is greater.



### 2.3.2 <u>High and Low Temperatures Electrical Measurements</u>

Characteristics	Symbols	Test Method and Conditions	Tolerance		Units	
		(Note 1)		Min	Max	
Capacitance	С	ESCC No. 3012				μF
		T <sub>amb</sub> = -55 (+3 -0)°C:	±10% ±20%	0.828C <sub>n</sub> 0.736C <sub>n</sub>	1.1C <sub>n</sub> 1.2C <sub>n</sub>	
		$T_{amb} = +85 \pm 3^{\circ}C$ :	±10% ±20%	0.9C <sub>n</sub> 0.8C <sub>n</sub>	1.188C <sub>n</sub> 1.296C <sub>n</sub>	
		T <sub>amb</sub> = +125 (+0 -3)°C:	±10% ±20%	0.9C <sub>n</sub> 0.8C <sub>n</sub>	1.232C <sub>n</sub> 1.344C <sub>n</sub>	
DC Leakage	IL.	ESCC No. 3012	All			μΑ
Current	Tan	$T_{amb} = +85 \pm 3^{\circ}C, V = U_{R} \pm 2\%$ :		-	0.1C <sub>n</sub> x U <sub>R</sub> or (2) 1	
		$T_{amb} = +125 (+0 -3)^{\circ}C, V = U_{C} \pm 2\%$ :		-	0.125C <sub>n</sub> x U <sub>R</sub> or (2)	
Dissipation	DF	ESCC No. 3012	All			%
Factor		T <sub>amb</sub> = -55 (+3 -0)°C:		-	9	
		$T_{amb} = +85 \pm 3^{\circ}C$ :		-	7.2	
		T <sub>amb</sub> = +125 (+0 -3)°C:		-	9	

- 1. Measurements shall be performed on a sample of 5 components from each manufacturing lot and each capacitance value with 0 failures allowed. In the event of any failure a 100% inspection may be performed.
- Whichever is greater.



# 2.4 <u>INTERMEDIATE AND END-POINT ELECTRICAL MEASUREMENTS</u>

Unless otherwise specified, the measurements shall be performed at  $T_{amb}$  = +22 ±3°C.

Unless otherwise specified the test methods and test conditions shall be as per the corresponding test defined in Para. 2.3.1 Room Temperature Electrical Measurements.

Test Reference per	Characteristics	Symbols	Lin	Units	
ESCC No. 3012			Min	Max	
Mounting					
Initial Measurements	Capacitance	С	Not	te 1	μF
Final Measurements	Capacitance	С	Record Value		μF
	Capacitance Change	ΔC/C	-5	+5	%
	DC Leakage Current	IL	Not	te 1	μΑ
	Dissipation Factor	DF	Not	te 1	%
Robustness of Terminations					
Initial Measurements	Capacitance	С	Record Va	lue, Note 2	μF
Final Measurements	Capacitance	С	Record Value		μF
	Capacitance Change	ΔC/C	-5	+5	% (2)
Rapid Change of Temperature					
Initial Measurements	Capacitance	С	Record Value, Note 2		μF
Final Measurements	Capacitance	С	Record	d Value	μF
	Capacitance Change	ΔC/C	-5	+5	% (2)
	DC Leakage Current	IL	Not	te 1	μA
	Dissipation Factor	DF	Not	te 1	%
Vibration					
During Last Sweep Cycle	No intermittent contact ≥ 0.5ms, arcing, or open/short circuits	-	-	-	-
Climatic Sequence					
Initial Measurements	Capacitance	С	Record Va	lue, Note 2	μF
Dry Heat	DC Leakage Current (at +125°C; Uc)	lι	Not	Note 3	
Final Measurements	Capacitance	С	Record	d Value	μF
	Capacitance Change	ΔC/C	-5	+5	% (2)
	DC Leakage Current	IL	Not	te 1	μΑ
	Dissipation Factor	DF	Not	te 4	%



ISSUE 10

Test Reference per	Characteristics	Symbols	Limits		Units
ESCC No. 3012			Min	Max	
High and Low Temperature Stability					
Step 1 (at +22°C)	Capacitance	С	Record Value, Note 2		μF
	DC Leakage Current	IL	Notes 1, 2		μΑ
	Dissipation Factor	DF	Notes 1, 2		%
Step 2 (at -55°C)	Capacitance	С	Note 3		μF
	DC Leakage Current	IL	Note 3		μΑ
	Dissipation Factor	DF	Note 3		%
Step 3 (at +22°C)	Capacitance	С	Record Value		μF
	Capacitance Change from Step 1	ΔC/C	-5	+5	%
	DC Leakage Current	IL	Note	1	μΑ
	Dissipation Factor	DF	Note 1		%
Step 4 (at +85°C)	Capacitance	С	Note 3		μF
	DC Leakage Current	IL	Note	3	μΑ
	Dissipation Factor	DF	Note 3		%
Step 5 (at +125°C)	Capacitance	С	Note 3		μF
	DC Leakage Current	IL	Note	3	μΑ
	Dissipation Factor	DF	Note 3		%
Step 6 (at +22°C)	Capacitance	С	Record Value		μF
	Capacitance Change from Step 1	ΔC/C	-5	+5	%
	DC Leakage Current	IL	Note	1	μA
	Dissipation Factor	DF	Note 1		%
Surge Voltage					
Initial Measurements	Capacitance	С	Record Value, Note 2		μF
Final Measurements	Capacitance	С	Record \	√alue	μF
	Capacitance Change	ΔC/C	-5	+5	% (2)
	DC Leakage Current	IL	Note 1		μΑ
	Dissipation Factor	DF	Note 1		%
Damp Heat, Steady State					
Initial Measurements	Capacitance	С	Record Valu	e, Note 2	μF
Final Measurements	Capacitance	С	Record Value		μF
	Capacitance Change	ΔC/C	-5	+5	% (2)
	DC Leakage Current	IL	Note 1		μA
	Dissipation Factor	DF	Note 4		%

ISSUE 10



No. 3012/001

Test Reference per	Characteristics	Symbols	Limits		Units
ESCC No. 3012			Min	Max	
Operating Life				•	
Initial Measurements	Capacitance	С	Record Value, Note 2		μF
Intermediate Measurements (250h and 1000h)(Note 7)	DC Leakage Current (at T1 = +85°C)	ΙL	Note 5		μA
	DC Leakage Current (at T2 = +125°C)	IL	Note 5		μA
Intermediate Measurements (250h)(Note 8)	DC Leakage Current (at T1 = +85°C)	IL	Note 5		μA
Final Measurements	Capacitance	С	Record Value		μF
(1000h or 2000h)(Note 9)	Capacitance Change	ΔC/C	-5	+5	% (2)
	DC Leakage Current	IL	Note 6		μΑ
	Dissipation Factor	DF	Note 1		%

- 1. As specified in Para. 2.3.1.
- 2. Component characteristic measurements (as applicable) recorded during the final measurements during Mounting may be used for this test. In this case, Capacitance Change for this test shall be referred to the final Capacitance measurement during Mounting.
- 3. As specified in Para. 2.3.2.
- 4. 1.2× the limit specified in Para. 2.3.1.
- 5. 1.25× the limit specified in Para. 2.3.2.
- 6. 1.25× the limit specified in Para. 2.3.1.
- 7. Applicable to Qualification Testing, and to Periodic Testing for renewal of qualification after lapse.
- 8. Applicable to Periodic Testing for extension of qualification.
- 9. 1000 hours is applicable to Periodic Testing for extension of qualification. 2000 hours is applicable to Qualification Testing, and to Periodic Testing for renewal of qualification after lapse.



# **APPENDIX A**

# AGREED DEVIATIONS FOR KYOCERA AVX COMPONENTS s.r.o. (CZ)

Items Affected	Description of Deviations			
Para. 2.1.1, Deviations from the Generic Specification:	Internal Visual Inspection: Need not be performed immediately prior to encapsulation but may be performed at verticus at a resolution as a position in the DID.			
Deviations from Special In-Process Controls - Chart F2	at various stages during production, as specified in the PID.			
Para. 2.1.1, Deviations from the Generic Specification:	External Visual Inspection: Visible base material is permitted on the edges of terminals (there may be no			
Deviations from Screening Tests – Chart F3,	plating on edges).			
Deviations from Qualification and Periodic Testing - Chart F4				